

5-TAP SIP DELAY LINE

$$T_D/T_R = 3$$

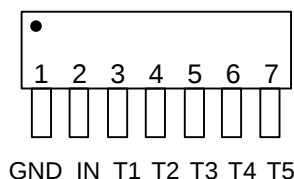
(SERIES 1505)



FEATURES

- 5 taps of equal delay increment
- Very narrow device (SIP package)
- Stackable for PC board economy
- Low profile
- Epoxy encapsulated
- Meets or exceeds MIL-D-23859C

PACKAGES



1505-xxz

xx = Delay (T_D)

z = Impedance Code

FUNCTIONAL DESCRIPTION

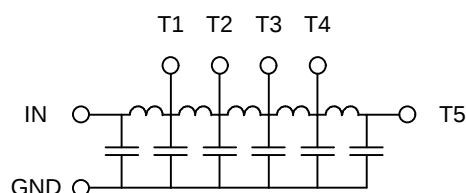
The 1505-series device is a fixed, single-input, five-output, passive delay line. The signal input (IN) is reproduced at the outputs (T1-T5) in equal increments. The delay from IN to T5 (T_D) is given by the device dash number. The characteristic impedance of the line is given by the letter code that follows the dash number (See Table). The rise time (T_R) of the line is 33% of T_D , and the 3dB bandwidth is given by $1.05 / T_D$.

PIN DESCRIPTIONS

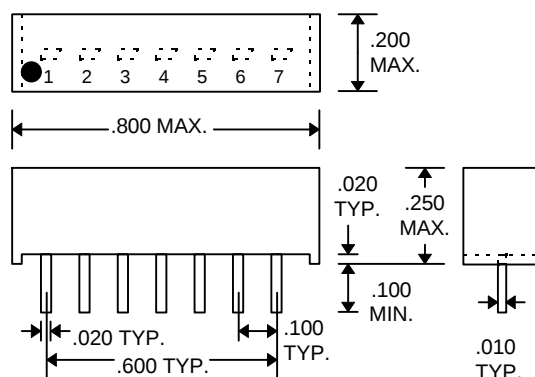
IN Signal Input
T1-T5 Tap Outputs
GND Ground

SERIES SPECIFICATIONS

- Dielectric breakdown: 50 Vdc
- Distortion @ output: 10% max.
- Operating temperature: -55°C to +125°C
- Storage temperature: -55°C to +125°C
- Temperature coefficient: 100 PPM/°C



Functional Diagram



Package Dimensions

DASH NUMBER SPECIFICATIONS

Part Number	T_D (ns)	Delay per Tap (ns)	T_R (ns)	Impedance (Ω)	R_{DC} (Ω)
1505-5A	5.0 ± 1.0	1.0 ± 0.3	2.0	50	0.6
1505-10A	10.0 ± 1.0	2.0 ± 0.4	3.0	50	0.6
1505-20A	20.0 ± 1.5	4.0 ± 0.6	6.0	50	0.7
1505-30A	30.0 ± 2.0	6.0 ± 1.0	9.0	50	0.7
1505-40A	40.0 ± 2.5	8.0 ± 1.5	12.0	50	0.9
1505-50A	50.0 ± 3.0	10.0 ± 1.8	15.0	50	1.0
1505-60A	60.0 ± 3.0	12.0 ± 2.0	18.0	50	1.2
1505-70A	70.0 ± 3.5	14.0 ± 2.0	21.0	50	1.4
1505-80A	80.0 ± 4.0	16.0 ± 2.0	24.0	50	1.6
1505-90A	90.0 ± 5.0	18.0 ± 3.0	27.0	50	1.8
1505-100A	100 ± 5.0	20.0 ± 3.0	30.0	50	2.0
1505-5B	5.0 ± 1.0	1.0 ± 0.3	2.0	100	0.7
1505-10B	10.0 ± 1.0	2.0 ± 0.4	3.0	100	0.7
1505-20B	20.0 ± 1.5	4.0 ± 0.6	6.0	100	1.0
1505-30B	30.0 ± 2.0	6.0 ± 1.0	9.0	100	1.5
1505-40B	40.0 ± 2.5	8.0 ± 1.5	12.0	100	1.8
1505-50B	50.0 ± 3.0	10.0 ± 1.8	15.0	100	2.0
1505-60B	60.0 ± 3.0	12.0 ± 2.0	18.0	100	2.0
1505-75B	75.0 ± 3.5	15.0 ± 2.0	24.0	100	2.5
1505-100B	100 ± 5.0	20.0 ± 3.0	30.0	100	2.5
1505-30C	30.0 ± 2.0	6.0 ± 1.0	9.0	200	2.5
1505-50C	50.0 ± 3.0	10.0 ± 1.8	15.0	200	3.0
1505-60C	60.0 ± 3.0	12.0 ± 2.0	18.0	200	3.5
1505-100C	100 ± 5.0	20.0 ± 3.0	30.0	200	6.0
1505-50G	50.0 ± 3.0	10.0 ± 1.8	15.0	500	5.0
1505-100G	100 ± 5.0	20.0 ± 3.0	30.0	500	15.0
1505-200G	200 ± 10.0	40.0 ± 6.0	60.0	500	21.0
1505-300G	300 ± 15.0	60.0 ± 8.0	90.0	500	29.0

PASSIVE DELAY LINE TEST SPECIFICATIONS

TEST CONDITIONS

INPUT:

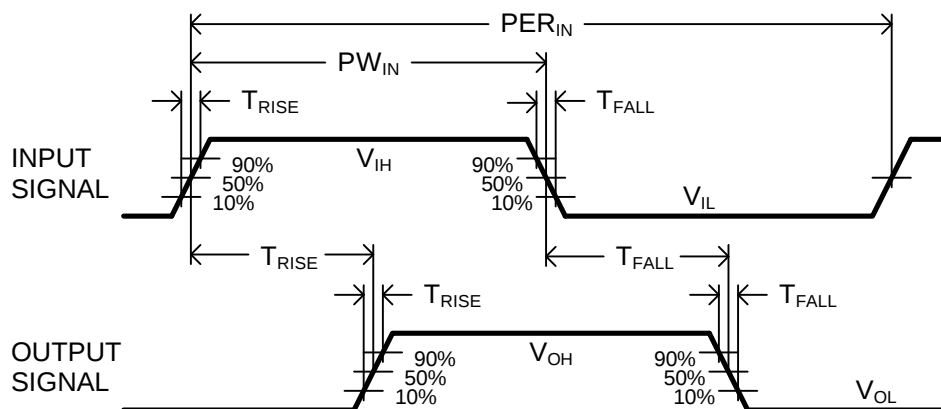
Ambient Temperature: $25^{\circ}\text{C} \pm 3^{\circ}\text{C}$
Input Pulse: High = 3.0V typical
 Low = 0.0V typical
Source Impedance: 50Ω Max.
Rise/Fall Time: 3.0 ns Max. (measured at 10% and 90% levels)

OUTPUT:

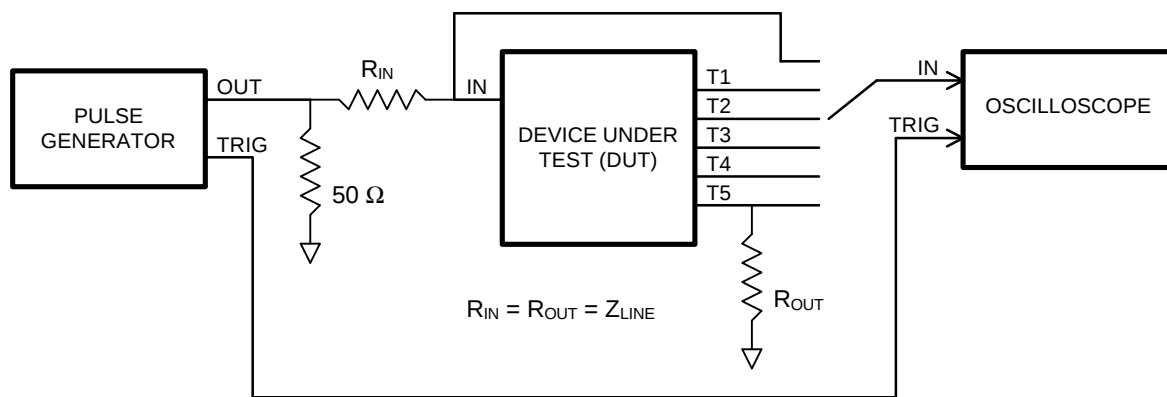
R_{load} : $10\text{M}\Omega$
 C_{load} : 10pf
Threshold: 50% (Rising & Falling)

Pulse Width ($T_D \leq 75\text{ns}$): $PW_{\text{IN}} = 100\text{ns}$
Period ($T_D \leq 75\text{ns}$): $PER_{\text{IN}} = 1000\text{ns}$
Pulse Width ($T_D > 75\text{ns}$): $PW_{\text{IN}} = 2 \times T_D$
Period ($T_D > 75\text{ns}$): $PER_{\text{IN}} = 10 \times T_D$

NOTE: The above conditions are for test only and do not in any way restrict the operation of the device.



Timing Diagram For Testing



Test Setup